

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/662,073 DODGE ET AL.	
		Examiner	Art Unit	Page 1 of 1 Karin M. Reichle 3761

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-RE38,444	02-2004	Wada et al.	524/559
*	B	US-5,032,628	07-1991	Choi et al.	523/409
*	C	US-5,087,506	02-1992	Palumbo, Gianfranco	428/194
*	D	US-5,520,673	05-1996	Yarbrough et al.	604/378
*	E	US-5,610,220	03-1997	Klimmek et al.	524/417
*	F	US-5,728,082	03-1998	Gustafsson et al.	604/368
*	G	US-5,856,410	01-1999	Carrico et al.	525/362
*	H	US-5,944,440	08-1999	Kleinschmit et al.	403/271
*	I	US-5,760,080	06-1998	Wada et al.	524/559
*	J	US-5,843,063	12-1998	Anderson et al.	604/378
*	K	US-6,090,875	07-2000	Staples et al.	524/313
*	L	US-6,433,058	08-2002	Weir et al.	524/431
*	M	US-2005/0059762	03-2005	Jonas et al.	524/425

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 712659 A1	05-1996	European Patent	WADA et al.	
	O	WO 9415651 A1	07-1994	World Intellect	KLIMMEK et al.	
	P	WO 9852979 A1	11-1998	World Intellect	CARRICO et al.	
	Q	WO 200141818 A1	06-2001	World Intellect	WILSON, L R	
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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